

## Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$

## Applications

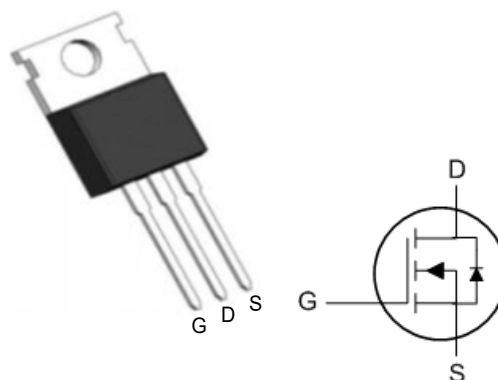
- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

## Product Summary



| BVDSS | RDSON | ID  |
|-------|-------|-----|
| 100V  | 5mΩ   | 80A |

## TO220AB Pin Configuration



## Absolute Maximum Ratings

| Symbol                      | Parameter                                      | Rating     | Units            |
|-----------------------------|------------------------------------------------|------------|------------------|
| $V_{DS}$                    | Drain-Source Voltage                           | 100        | V                |
| $V_{GS}$                    | Gate-Source Voltage                            | $\pm 20$   | V                |
| $I_D@T_C=25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10V^{1,6}$ | 80         | A                |
| $I_D@T_C=100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10V^{1,6}$ | 56         | A                |
| $I_{DM}$                    | Pulsed Drain Current <sup>2</sup>              | 320        | A                |
| EAS                         | Single Pulse Avalanche Energy <sup>3</sup>     | 238        | mJ               |
| $I_{AS}$                    | Avalanche Current                              | ---        | A                |
| $P_D@T_C=25^\circ\text{C}$  | Total Power Dissipation <sup>4</sup>           | 111        | W                |
| $T_{STG}$                   | Storage Temperature Range                      | -55 to 150 | $^\circ\text{C}$ |
| $T_J$                       | Operating Junction Temperature Range           | -55 to 150 | $^\circ\text{C}$ |

## Thermal Data

| Symbol          | Parameter                                        | Typ. | Max. | Unit               |
|-----------------|--------------------------------------------------|------|------|--------------------|
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient <sup>1</sup> | ---  | 1.1  | $^\circ\text{C/W}$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case <sup>1</sup>    | ---  | 40   | $^\circ\text{C/W}$ |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

| Symbol                       | Parameter                                      | Conditions                                            | Min. | Typ. | Max.      | Unit                |
|------------------------------|------------------------------------------------|-------------------------------------------------------|------|------|-----------|---------------------|
| $BV_{DSS}$                   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V, I_D=250\mu A$                             | 100  | ---  | ---       | V                   |
| $\Delta BV_{DSS}/\Delta T_J$ | $BV_{DSS}$ Temperature Coefficient             | Reference to $25^\circ\text{C}$ , $I_D=1mA$           | ---  | ---  | ---       | $V/^\circ\text{C}$  |
| $R_{DS(on)}$                 | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=10V, I_D=18A$                                 | ---  | 5    | 6.3       | $m\Omega$           |
|                              |                                                | $V_{GS}=4.5V, I_D=18A$                                | ---  | 7    | 8.5       |                     |
| $V_{GS(th)}$                 | Gate Threshold Voltage                         | $V_{GS}=V_{DS}, I_D=250\mu A$                         | 1.2  | 1.7  | 2.5       | V                   |
| $\Delta V_{GS(th)}$          | $V_{GS(th)}$ Temperature Coefficient           |                                                       | ---  | ---  | ---       | $mV/^\circ\text{C}$ |
| $I_{DSS}$                    | Drain-Source Leakage Current                   | $V_{DS}=80V, V_{GS}=0V, T_J=25^\circ\text{C}$         | ---  | ---  | 1         | $\mu A$             |
|                              |                                                | $V_{DS}=80V, V_{GS}=0V, T_J=100^\circ\text{C}$        | ---  | ---  | ---       |                     |
| $I_{GSS}$                    | Gate-Source Leakage Current                    | $V_{GS}=\pm 20V, V_{DS}=0V$                           | ---  | ---  | $\pm 100$ | nA                  |
| $g_{fs}$                     | Forward Transconductance                       | $V_{DS}=10V, I_D=15A$                                 | ---  | ---  | ---       | S                   |
| $R_g$                        | Gate Resistance                                | $V_{DS}=0V, V_{GS}=0V, f=1MHz$                        | ---  | ---  | ---       | $\Omega$            |
| $Q_g$                        | Total Gate Charge                              | $V_{DS}=50V, V_{GS}=10V, I_D=18A$                     | ---  | 44   | ---       | nC                  |
| $Q_{gs}$                     | Gate-Source Charge                             |                                                       | ---  | 9    | ---       |                     |
| $Q_{gd}$                     | Gate-Drain Charge                              |                                                       | ---  | 9    | ---       |                     |
| $T_{d(on)}$                  | Turn-On Delay Time                             | $V_{DD}=50V, I_D=18A,$<br>$R_G=6.2\Omega, V_{GS}=10V$ | ---  | 11   | ---       | ns                  |
| $T_r$                        | Rise Time                                      |                                                       | ---  | 18   | ---       |                     |
| $T_{d(off)}$                 | Turn-Off Delay Time                            |                                                       | ---  | 50   | ---       |                     |
| $T_f$                        | Fall Time                                      |                                                       | ---  | 40   | ---       |                     |
| $C_{iss}$                    | Input Capacitance                              | $V_{DS}=50V, V_{GS}=0V, f=1MHz$                       | ---  | 2615 | ---       | pF                  |
| $C_{oss}$                    | Output Capacitance                             |                                                       | ---  | 806  | ---       |                     |
| $C_{rss}$                    | Reverse Transfer Capacitance                   |                                                       | ---  | 22   | ---       |                     |

**Diode Characteristics**

| Symbol   | Parameter                                | Conditions                                 | Min. | Typ. | Max. | Unit |
|----------|------------------------------------------|--------------------------------------------|------|------|------|------|
| $I_S$    | Continuous Source Current <sup>1,4</sup> | $V_G=V_D=0V$ , Force Current               | ---  | ---  | 80   | A    |
| $V_{SD}$ | Diode Forward Voltage <sup>2</sup>       | $V_{GS}=0V, I_S=18A, T_J=25^\circ\text{C}$ | ---  | ---  | 1.2  | V    |
| $t_{rr}$ | Reverse Recovery Time                    | $I_F=18A, di/dt=100A/\mu s$ ,              | ---  | 49   | ---  | nS   |
| $Q_{rr}$ | Reverse Recovery Charge                  | $T_J=25^\circ\text{C}$                     | ---  | 67   | ---  | nC   |

- Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
  2.  $E_{AS}$  condition: Starting  $T_J=25^\circ\text{C}$ ,  $V_{DD}=50V$ ,  $V_G=10V$ ,  $R_G=25\Omega$ ,  $L=3mH$ ,  $I_{AS}=12A$ ,  $V_{DD}=0V$  during time in avalanche.
  3.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB.
  4. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 0.5\%$ .

## Typical Performance Characteristics

Figure 1: Power De-rating

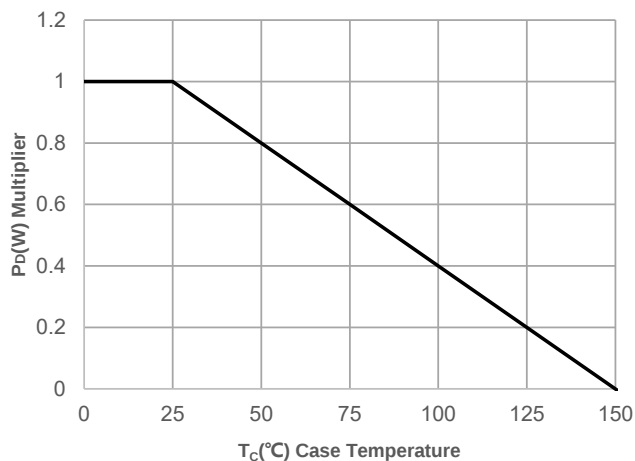


Figure 2: Current De-rating

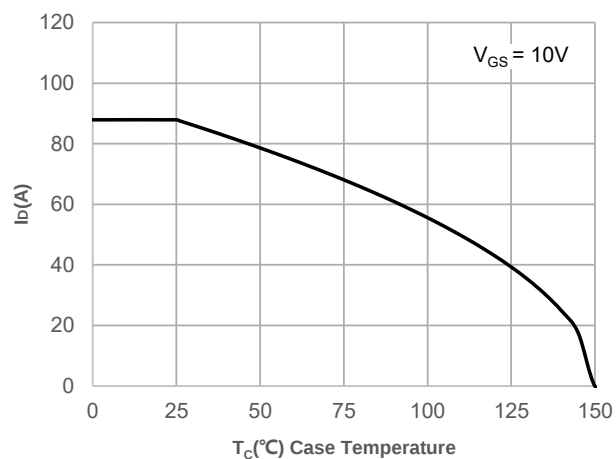


Figure 3: Normalized Maximum Transient Thermal Impedance

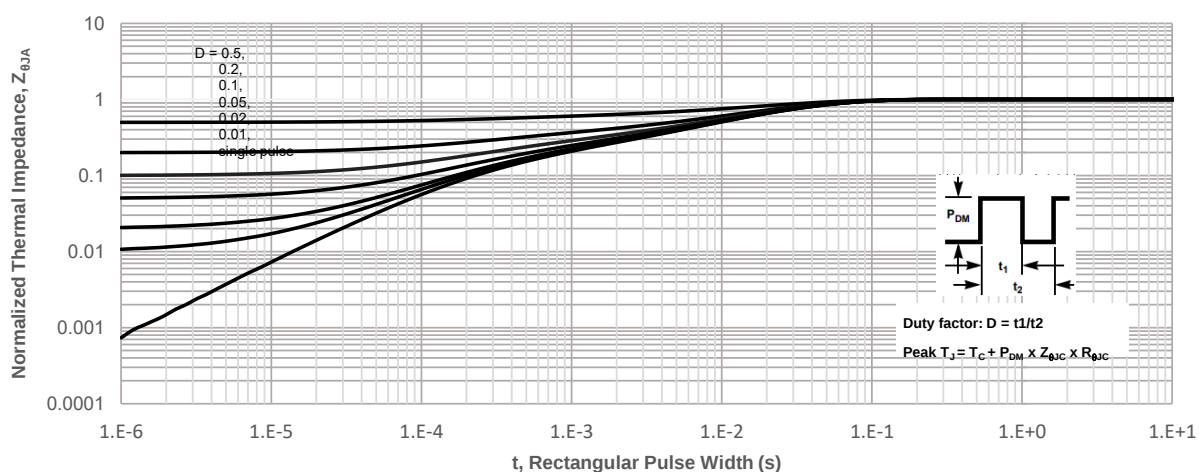
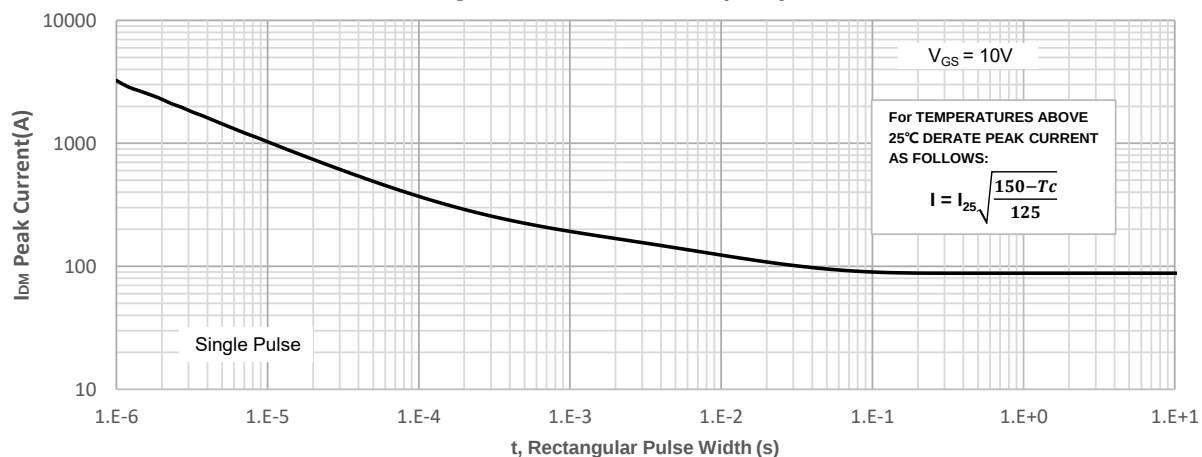


Figure 4: Peak Current Capacity



## Typical Performance Characteristics

Figure 5: Output Characteristics

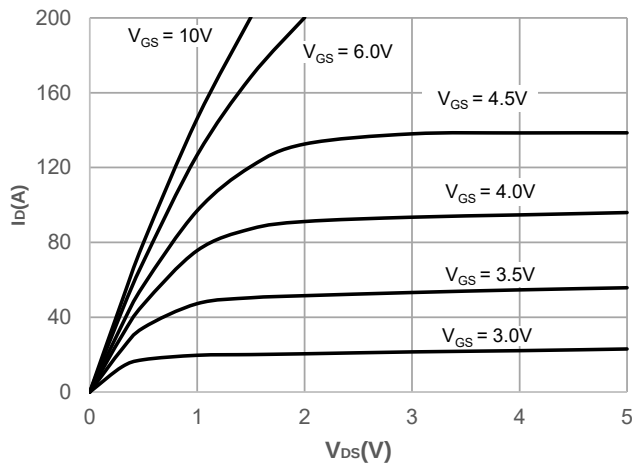


Figure 6: Typical Transfer Characteristics

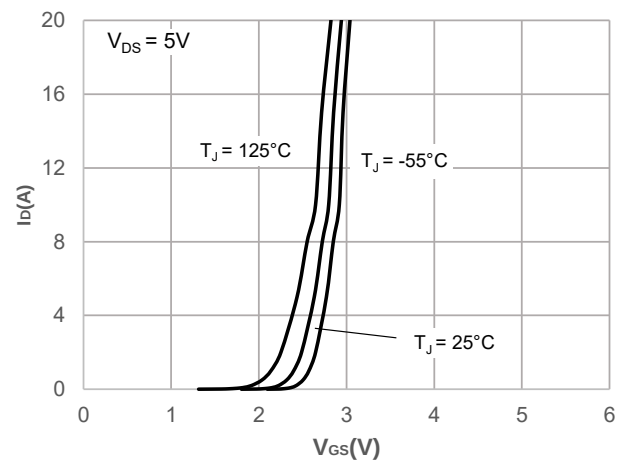


Figure 7: On-resistance vs. Drain Current

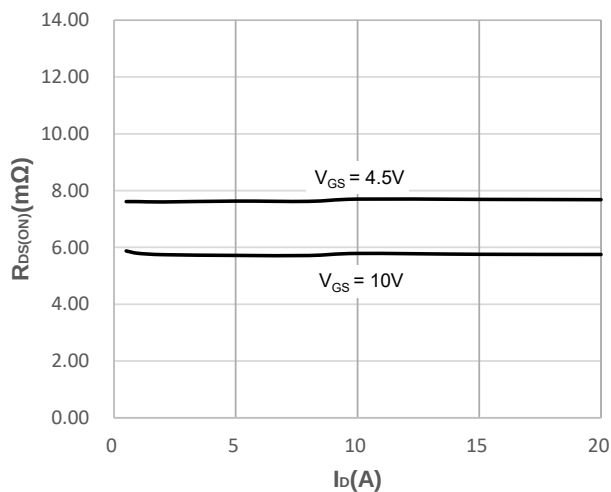


Figure 8: Body Diode Characteristics

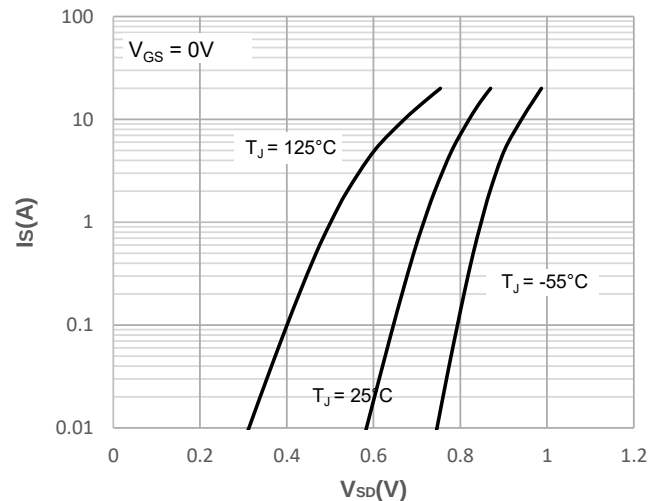


Figure 9: Gate Charge Characteristics

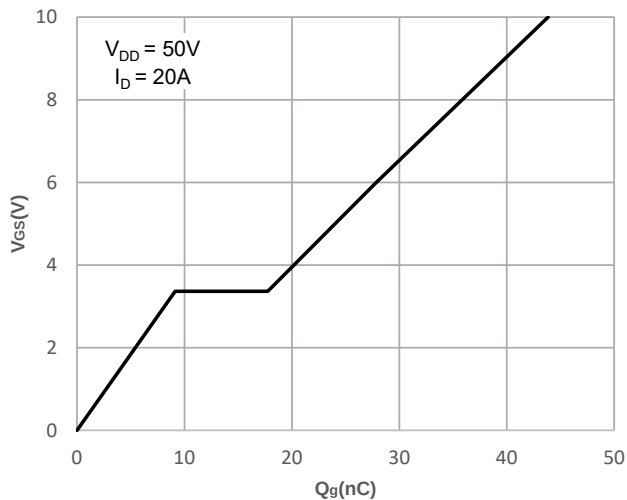
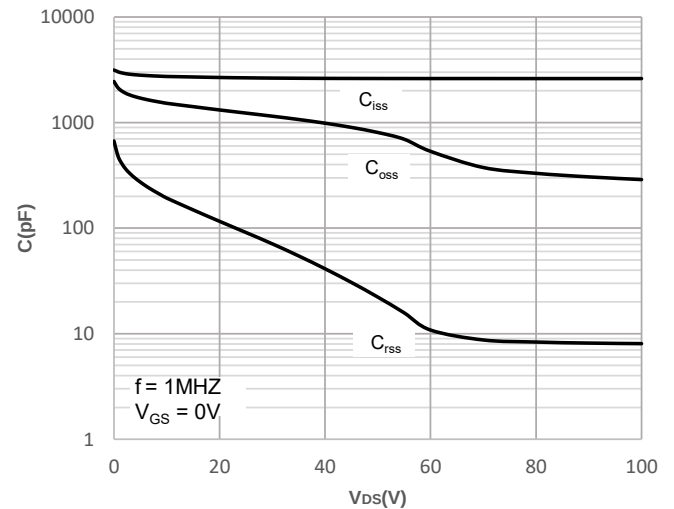
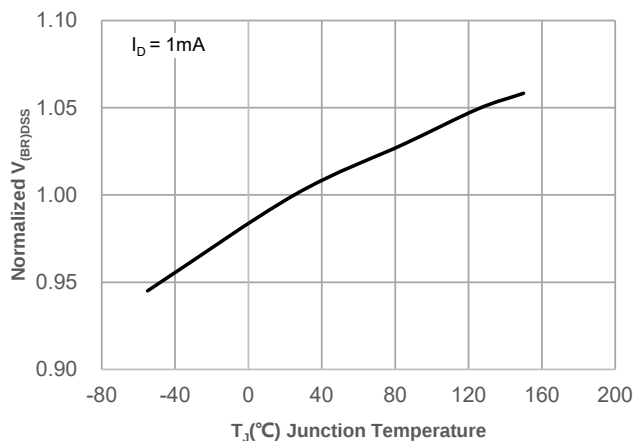


Figure 10: Capacitance Characteristics

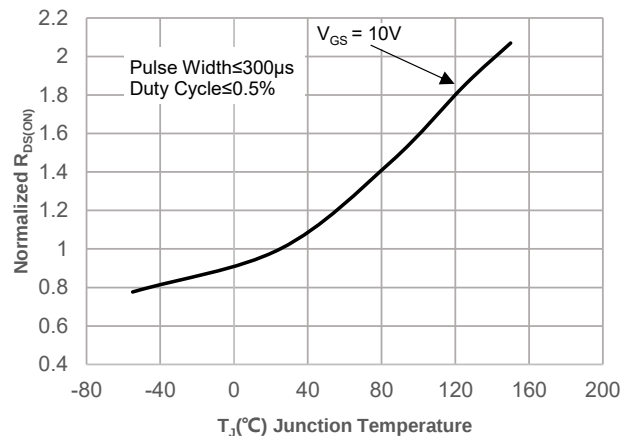


## Typical Performance Characteristics

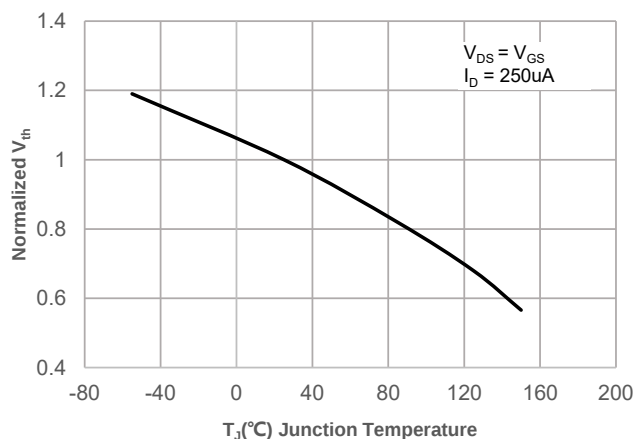
**Figure 11: Normalized Breakdown voltage vs. Junction Temperature**



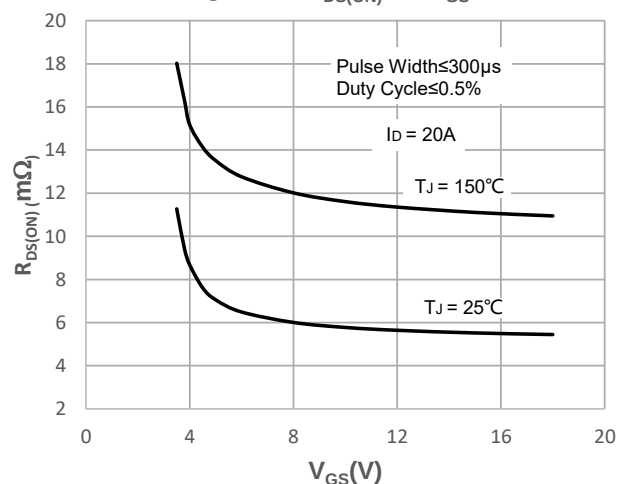
**Figure 12: Normalized on Resistance vs. Junction Temperature**



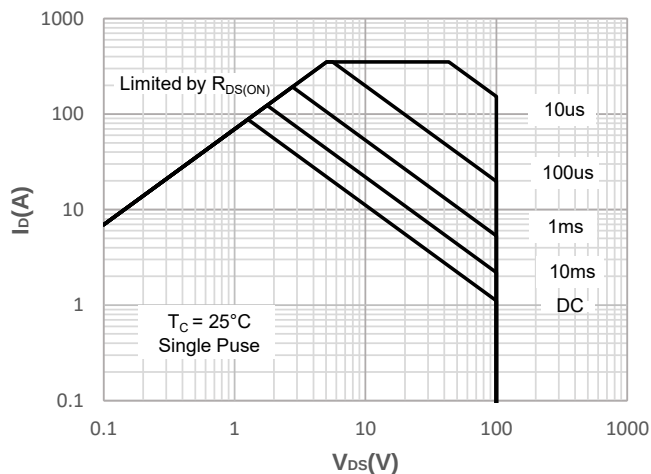
**Figure 13: Normalized Threshold Voltage vs. Junction Temperature**



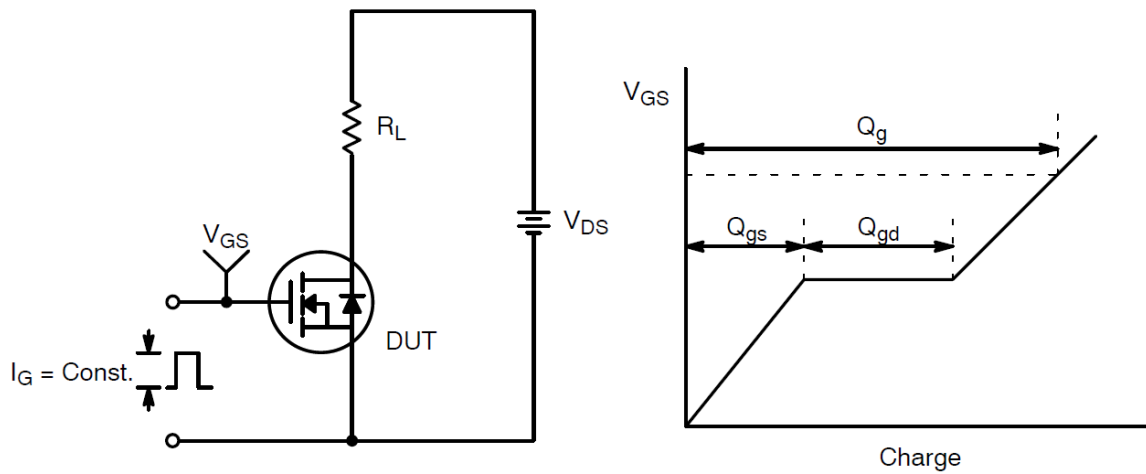
**Figure 14:  $R_{DS(ON)}$  vs.  $V_{GS}$**



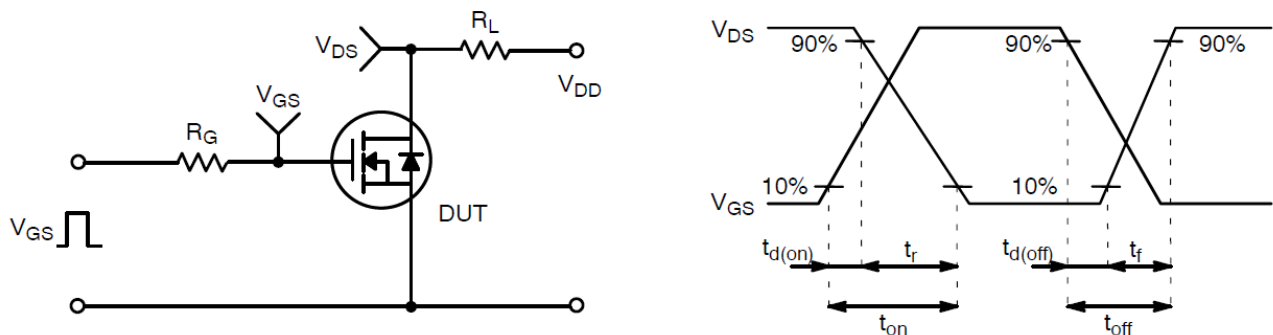
**Figure 15: Maximum Safe Operating Area**



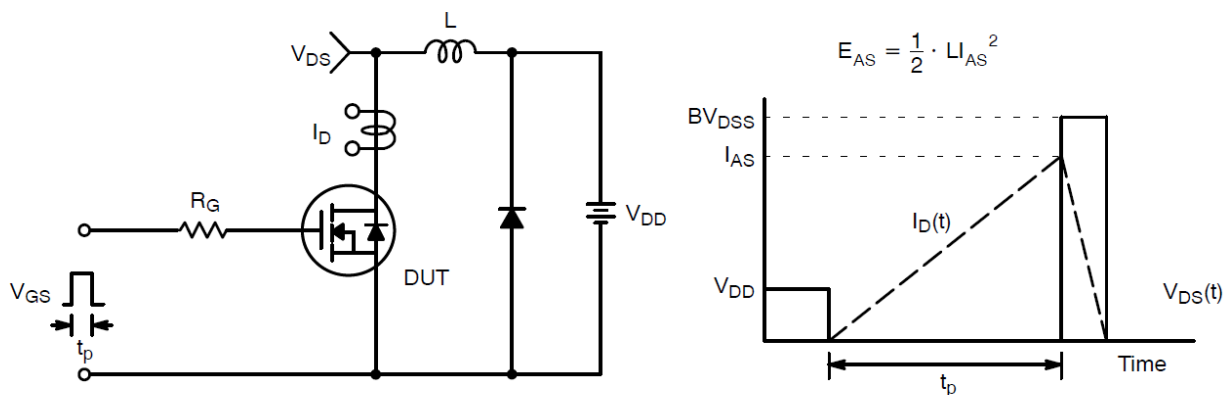
## Test Circuit and Waveform:



**Gate Charge Test Circuit & Waveform**

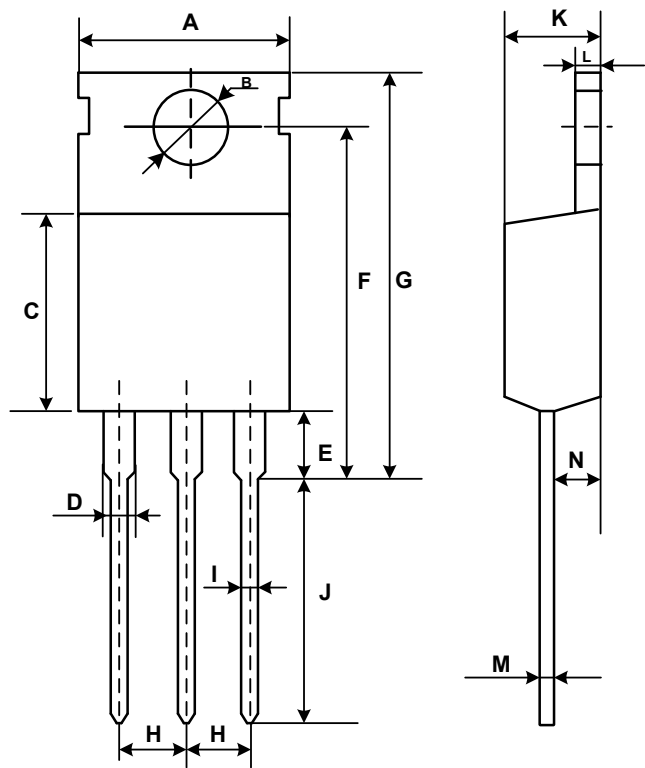


**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching Test Circuit & Waveforms**

Mechanical Dimensions for TO-220



COMMON DIMENSIONS

| SYMBOL | MM       |       |
|--------|----------|-------|
|        | MIN      | MAX   |
| A      | 9.70     | 10.30 |
| B      | 3.40     | 3.80  |
| C      | 8.80     | 9.40  |
| D      | 1.17     | 1.47  |
| E      | 2.60     | 3.50  |
| F      | 15.10    | 16.70 |
| G      | 19.55MAX |       |
| H      | 2.54REF  |       |
| I      | 0.70     | 0.95  |
| J      | 9.35     | 11.00 |
| K      | 4.30     | 4.77  |
| L      | 1.20     | 1.45  |
| M      | 0.40     | 0.65  |
| N      | 2.20     | 2.60  |